

# **12-BIT 200-KSPS 11-CHANNEL LOW-POWER SERIAL ANALOG-TO-DIGITAL CONVERTER WITH INTERNAL REFERENCE**

# **<sup>1</sup>FEATURES**

- **12-Bit-Resolution Analog-to-Digital Converter (ADC)**
- **Up to 200-KSPS (150-KSPS for 3 V) Throughput Bit With 12-Output Mode Over Operating Temperature Range**
- •**11 Analog Input Channels**
- •**3 Built-In Self-Test Modes**
- • **Programmable Reference (2.048 V/4.096 V Internal or External)**
- •**Inherent Sample and Hold Function**
- **Linearity Error...±1 LSB Max**
- •**On-Chip Conversion Clock**
- • **Programmable Conversion Status Output: INT or EOC**
- **Unipolar or Bipolar Output Operation**
- •**Programmable MSB or LSB First**
- 
- •**Programmable Output Data Length**
- • **SPI Compatible Serial Interface With I/O Clock Frequencies up to 15 MHz (CPOL <sup>=</sup> 0, CPHA <sup>=</sup> 0)**

## **SUPPORTS DEFENSE, AEROSPACE, AND MEDICAL APPLICATIONS**

- •**Controlled Baseline**
- •
- 
- **Available in Military (–55°C/125°C) Temperature Range**(1)
- •**Extended Product Life Cycle**
- •
- •

# **APPLICATIONS**

- **Industrial Process Control**
- **Portable Data Logging**
- •**Battery Powered Instruments**
- •**Automotive**
- (1) Additional temperature ranges are available contact factory

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### **(TOP VIEW) PW AND DW PACKAGE**



# **DESCRIPTION**

The TLV2556 is <sup>a</sup> 12-bit, switched-capacitor, successive-approximation, analog-to-digital converter (ADC). The ADC has three control inputs [chip select **Programmable Power Down** (CS), the input-output clock, and the address/control input (DATAIN)], designed for communication with the serial port of <sup>a</sup> host processor or peripheral through <sup>a</sup> serial 3-state output.

In addition to the high-speed converter and versatile control capability, the device has an on-chip 14-channel multiplexer that can select any one of 11 inputs or any one of three internal self-test voltages using configuration register 1. The sample-and-hold function is automatic. At the end of conversion, when **One Assembly/Test Site COL** programmed as EOC, the pin 19 output goes high to **One Fabrication Site** indicate that conversion is complete. If pin 19 is programmed as  $\overline{\text{INT}}$ , the signal goes low when the conversion is complete. The converter incorporated in the device features differential, high-impedance reference inputs that facilitate ratiometric conversion, **Extended Product-Change Notification** scaling, and isolation of analog circuitry from logic **Product Traceability and supply noise. A switched-capacitor design allows** and supply noise. A switched-capacitor design allows low-error conversion over the full operating temperature range. An internal reference is available and its voltage level is programmable via configuration register 2 (CFGR2).

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# **ORDERING INFORMATION(1)**



(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at [www.ti.com](http://www.ti.com).

(2) Package drawings, thermal data, and symbolization are available at [www.ti.com/packaging](http://www.ti.com/packaging).

#### **Functional Block Diagram VCC REF+ REF− 20 14 13** ÷







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### **TERMINAL FUNCTIONS**





# **ABSOLUTE MAXIMUM RATINGS(1)(2)**

over operating free-air temperature range (unless otherwise noted)



(1) Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *recommended operating conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltage values are with respect to the GND terminal with REF– and GND wired together (unless otherwise noted).

# **RECOMMENDED OPERATING CONDITIONS**



(1) Analog input voltages greater than the voltage applied to REF+ convert as all ones (111111111111), while input voltages less than the voltage applied to REF– convert as all zeros (000000000000).



# **ELECTRICAL CHARACTERISTICS**

over recommended operating free-air temperature range, V<sub>REF+</sub> = 5 V,

SCLK frequency = 15 MHz when V $_{\rm CC}$  = 5 V, V $_{\rm REF+}$  = 2.5 V,

SCLK frequency = 10 MHz when V $_{\rm CC}$  = 2.7 V (unless otherwise noted)



(1) All typical values are at  $V_{CC}$  = 5 V, T<sub>A</sub> = 25°C.

(2) The switch resistance is very nonlinear and varies with input voltage and supply voltage.

**INSTRUMENTS** 

**EXAS** 

# **EXTERNAL REFERENCE SPECIFICATIONS(1)**



(1) Add <sup>a</sup> 0.1-µF capacitor between REF+ and REF– pins when external reference is used.

(2) All typical values are at  $V_{CC} = 5$  V,  $T_A = 25^{\circ}$ C.

# **INTERNAL REFERENCE SPECIFICATIONS(1)**



(1) When an internal reference is used, the following conditions are required: a. Add 0.1-µF and 10-µF capacitors between REF+ and REF– pins. b. REF– must be connected to analog GND (the ground pin of the ADC).

(2) All typical values are at  $V_{CC}$  = 5 V, T<sub>A</sub> = 25°C.



## **OPERATING CHARACTERISTICS**

over recommended operating free-air temperature range,  $V_{REF+} = 5 V$ ,

SCLK frequency = 15 MHz when V $_{\rm CC}$  = 5 V, V $_{\rm REF+}$  = 2.5 V,

SCLK frequency = 10 MHz when V $_{\rm CC}$  = 2.7 V (unless otherwise noted)



(1) All typical values are at  $V_{CC} = 5$  V,  $T_A = 25^{\circ}C$ .<br>(2) Linearity error is the maximum deviation from

(5) Total unadjusted error comprises linearity, zero-scale, and full-scale errors.

(6) Both the input address and the output codes are expressed in positive logic.

Linearity error is the maximum deviation from the best straight line through the A/D transfer characteristics.

<sup>(3)</sup> Analog input voltages greater than the voltage applied to REF+ convert as all ones (111111111111), while input voltages less than the voltage applied to REF– convert as all zeros (000000000000).

<sup>(4)</sup> Gain error is the difference between the actual mid-step value and the nominal mid-step value in the transfer diagram at the specified gain point after the offset error has been adjusted to zero. Offset error is the difference between the actual mid-step value and the nominal mid-step value at the offset point.

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# **EXAS NSTRUMENTS**

# **TIMING CHARACTERISTICS(1)**

operating characteristics,  $V_{REF+} = 5 V$ , SCLK frequency = 15 MHz,  $V_{CC} = 5 V$ , load = 25 pF,  $T_A = -40°C$  to 85°C (unless otherwise noted)



(1) Timing parameters are not production tested.

(2) I/O CLOCK period <sup>=</sup> 8x [1/(I/O CLOCK frequency)] or 12x [1/(I/O CLOCK frequency)] or 16x [1/(I/O CLOCK frequency)] depends on I/O format selected.

**TEXAS** 

**INSTRUMENTS** 

# **TIMING CHARACTERISTICS(1)**

operating characteristics,  $V_{REF+}$  = 2.5 V, SCLK frequency = 10 MHz,  $V_{CC}$  = 2.7 V, load = 25 pF,  $T_A$ = -40°C to 85°C (unless otherwise noted)



(1) Timing parameters are not production tested.

(2) I/O CLOCK period <sup>=</sup> 8x [1/(I/O CLOCK frequency)] or 12x [1/(I/O CLOCK frequency)] or 16x [1/(I/O CLOCK frequency)] depends on I/O format selected.



**TYPICAL CHARACTERISTICS**

All typical curves are with internal reference unless specified otherwise. See the TLV2553 data sheet [\(SLAS354](http://www-s.ti.com/sc/techlit/SLAS354)) for typical curves using an external reference.

**[TLV2556-EP](http://focus.ti.com/docs/prod/folders/print/tlv2556-ep.html)**

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**AUTO POWER DOWN vs FREE-AIR TEMPERATURE**



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# **TYPICAL CHARACTERISTICS (continued)**



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# **TYPICAL CHARACTERISTICS (continued)**







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# **TYPICAL CHARACTERISTICS (continued)**



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Texas **INSTRUMENTS** 

# **TYPICAL CHARACTERISTICS (continued)**

All typical curves are with internal reference unless specified otherwise. See the TLV2553 data sheet ([SLAS354](http://www-s.ti.com/sc/techlit/SLAS354)) for typical curves using an external reference.



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# **TYPICAL CHARACTERISTICS (continued)**



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# **TYPICAL CHARACTERISTICS (continued)**





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# **TYPICAL CHARACTERISTICS (continued)**



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## **TYPICAL CHARACTERISTICS (continued)**



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# **TYPICAL CHARACTERISTICS (continued)**

All typical curves are with internal reference unless specified otherwise. See the TLV2553 data sheet ([SLAS354](http://www-s.ti.com/sc/techlit/SLAS354)) for typical curves using an external reference.



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## **PARAMETER MEASUREMENT INFORMATION**



**Figure 37. DATA OUT to Hi-Z Voltage Waveforms Figure 38. DATA IN and I/O CLOCK Voltage**



#### **Figure 39. CS and I/O CLOCK Voltage Waveforms Figure 40. I/O CLOCK and DATA OUT Voltage**













**Figure 41. I/O CLOCK and EOC Voltage Waveforms Figure 42. EOC and DATA OUT Voltage Waveforms**



**Figure 43. CS and EOC Voltage Waveforms Figure 44. I/O CLOCK and EOC Voltage Waveforms**

# **PARAMETER MEASUREMENT INFORMATION (continued)**

# **Timing Information**



**Figure 45. Timing for CFGR2 Configuration**

The host must configure CFGR2 before valid device conversions can begin. This can be accessed through command 1111. This can be done using 8, 12, or 16 I/O CLOCK clocks. (A minimum of 8 is required to fully program CFGR2.)

After CFGR2 is configured, the following cycle configures CFGR1 and <sup>a</sup> valid sample/conversion is performed. CS can be held low for each remaining cycle. First valid conversion output data is available on the third cycle after power up.

# **Timing Diagrams**

![](_page_21_Figure_9.jpeg)

A. To minimize errors caused by noise at  $\overline{CS}$ , the internal circuitry waits for a setup time after the  $\overline{CS}$  falling edge before responding to control input signals. Therefore, no attempt should be made to clock in an address until the minimum CS setup time has elapsed.

**Figure 46. Timing for 12-Clock Transfer Using CS With DATA OUT Set for MSB First**

![](_page_22_Picture_0.jpeg)

![](_page_22_Figure_1.jpeg)

![](_page_22_Figure_3.jpeg)

#### A. To minimize errors caused by noise at  $\overline{CS}$ , the internal circuitry waits for a setup time after the  $\overline{CS}$  falling edge before responding to control input signals. Therefore, no attempt should be made to clock in an address until the minimum CS setup time has elapsed.

**Figure 47. Timing for 12-Clock Transfer Not Using CS With DATA OUT Set for MSB First**

![](_page_22_Figure_6.jpeg)

A. To minimize errors caused by noise at  $\overline{CS}$ , the internal circuitry waits for a setup time after the  $\overline{CS}$  falling edge before responding to control input signals. Therefore, no attempt should be made to clock in an address until the minimum CS setup time has elapsed.

**Figure 48. Timing for 8-Clock Transfer Using CS With DATA OUT Set for MSB First**

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![](_page_23_Figure_3.jpeg)

**PARAMETER MEASUREMENT INFORMATION (continued)**

A. To minimize errors caused by noise at  $\overline{CS}$ , the internal circuitry waits for a setup time after the  $\overline{CS}$  falling edge before responding to control input signals. Therefore, no attempt should be made to clock in an address until the minimum CS setup time has elapsed.

![](_page_23_Figure_5.jpeg)

![](_page_23_Figure_6.jpeg)

A. To minimize errors caused by noise at  $\overline{CS}$ , the internal circuitry waits for a setup time after the  $\overline{CS}$  falling edge before responding to control input signals. Therefore, no attempt should be made to clock in an address until the minimum CS setup time has elapsed.

**Figure 50. Timing for 16-Clock Transfer Using CS With DATA OUT Set for MSB First**

![](_page_24_Figure_1.jpeg)

# **PARAMETER MEASUREMENT INFORMATION (continued)**

![](_page_24_Figure_5.jpeg)

A. To minimize errors caused by noise at  $\overline{CS}$ , the internal circuitry waits for a setup time after the  $\overline{CS}$  falling edge before responding to control input signals. Therefore, no attempt should be made to clock in an address until the minimum CS setup time has elapsed.

**Figure 51. Timing for 16-Clock Transfer Not Using CS With DATA OUT Set for MSB First**

![](_page_24_Figure_8.jpeg)

A. To minimize errors caused by noise at  $\overline{CS}$ , the internal circuitry waits for a setup time after the  $\overline{CS}$  falling edge before responding to control input signals. Therefore, no attempt should be made to clock in an address until the minimum CS setup time has elapsed.

### **Figure 52. Timing for Default Mode Using CS: (16-Clock Transfer, MSB First, External Reference, Pin 19 <sup>=</sup> EOC, Input <sup>=</sup> AIN0)**

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![](_page_25_Figure_3.jpeg)

# **PARAMETER MEASUREMENT INFORMATION (continued)**

A. To minimize errors caused by noise at  $\overline{CS}$ , the internal circuitry waits for a setup time after the  $\overline{CS}$  falling edge before responding to control input signals. Therefore, no attempt should be made to clock in an address until the minimum CS setup time has elapsed.

### **Figure 53. Timing for Default Mode Not Using CS: (16-Clock Transfer, MSB First, External Reference, Pin 19 <sup>=</sup> EOC, Input <sup>=</sup> AIN0)**

To remove the device from default mode, CFGR2–D0 must be reset to 0. Valid sample/convert cycles can resume on the cycle following the CFGR2 configuration.

![](_page_26_Picture_0.jpeg)

# **PRINCIPLES OF OPERATION**

Initially, with chip select (CS) high, I/O CLOCK and DATA IN are disabled and DATA OUT is in the high-impedance state. CS going low begins the conversion sequence by enabling I/O CLOCK and DATA IN and removes DATA OUT from the high-impedance state. The input data is an 8-bit data stream consisting of <sup>a</sup> 4-bit address or command (D7–D4) and <sup>a</sup> 4-bit configuration data (D3–D0). There are two sets of configuration registers, configuration register 1 – CFGR1 and configuration register 2 – CFGR2. CFGR1, which controls output data format configuration, consists of <sup>a</sup> 2-bit data length select (D3–D2), an output MSB or LSB first bit (D1), and <sup>a</sup> unipolar or bipolar output select bit (D0) that are applied to any command (from DATA IN) except for command 1111b. CFGR2, which provides configuration information other than data format, consists of <sup>a</sup> 2-bit reference select (D3–D2), an EOC/INT program bit (D1), and a default mode select bit (D0) that are applied to command 1111b. The I/O CLOCK sequence applied to the I/O CLOCK terminal transfers this data to the input data register. During this transfer, the I/O CLOCK sequence also shifts the previous conversion result from the output data register to DATA OUT. I/O CLOCK receives the input sequence of 8, 12, or 16 clock cycles long depending on the data-length selection in the input data register. Sampling of the analog input begins on the fourth falling edge of the input I/O CLOCK sequence and is held after the last falling edge of the I/O CLOCK sequence. The last falling edge of the I/O CLOCK sequence also takes EOC low (if pin 19 = EOC) and begins the conversion.

# **Converter Operation**

The operation of the converter is organized as <sup>a</sup> succession of three distinct cycles: 1) the data I/O cycle, 2) the sampling cycle, and 3) the conversion cycle. The first two are partially overlapped.

# **Data I/O Cycle**

The data I/O cycle is defined by the externally provided I/O CLOCK and lasts 8, 12, or 16 clock periods, depending on the selected output data length. During the I/O cycle, the following two operations take place simultaneously. An 8-bit data stream consisting of address/command and configuration information is provided to DATA IN. This data is shifted into the device on the rising edge of the first eight I/O CLOCK clocks. Data input is ignored after the first eight clocks during 12- or 16-clock I/O transfers. The data output, with <sup>a</sup> length of 8, 12, or 16 bits, is provided serially on DATA OUT. When  $\overline{CS}$  is held low, the first output data bit occurs on the rising edge of EOC. When CS is toggled between conversions, the first output data bit occurs on the falling edge of CS. This data is the result of the previous conversion period, and after the first output data bit, each succeeding bit is clocked out on the falling edge of each succeeding I/O CLOCK.

# **Sampling Period**

During the sampling period, one of the analog inputs is internally connected to the capacitor array of the converter to store the analog input signal. The converter starts sampling the selected input immediately after the four address/command bits have been clocked into the input data register. Sampling starts on the fourth falling edge of I/O CLOCK. The converter remains in the sampling mode until the eighth, twelfth, or sixteenth falling edge of I/O CLOCK depending on the data-length selection.

After the 8-bit data stream has been clocked in, DATA IN should be held at <sup>a</sup> fixed digital level until EOC goes high or INT goes low (indicating that the conversion is complete) to maximize the sampling accuracy and minimize the influence of external digital noise.

# **Conversion Cycle**

A conversion cycle is started only after the I/O cycle is completed, which minimizes the influence of external digital noise on the accuracy of the conversion. This cycle is transparent to the user because it is controlled by an internal clock (oscillator). The total conversion time is equal to 13.5 OSC clocks plus <sup>a</sup> small delay (~25 ns) to start the OSC. During the conversion period, the device performs <sup>a</sup> successive-approximation conversion on the analog input voltage.

When programmed as EOC, pin 19 goes low at the start of the conversion cycle and goes high when the conversion is complete and the output data register is latched. After EOC goes low, the analog input can be changed without affecting the conversion result. Since the delay from the falling edge of the last I/O CLOCK to the falling edge of EOC is fixed, any time-varying analog input signals can be digitized at <sup>a</sup> fixed rate without introducing systematic harmonic distortion or noise due to timing uncertainty.

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![](_page_27_Picture_2.jpeg)

When programmed as  $\overline{\text{INT}}$ , pin 19 goes low when the conversion is complete and the output data register is latched. The next I/O CLOCK rising edge clears the INT output. The time from the last I/O CLOCK falling edge to the falling  $\overline{\text{INT}}$  edge is equivalent to the EOC delay mentioned above plus the maximum conversion time.  $\overline{\text{INT}}$  is cancelled by (or brought to high) by either the next CS falling edge or the next SCLK rising edge (when CS is held low all of the time for multiple cycles). When  $\overline{CS}$  is held low continuously (for multiple cycles) MSB output occurs after the first rising edge of I/O CLOCK after EOC is inactive or the falling edge of INT.

## **Power Up and Initialization**

After power up, CS must be taken from high to low to begin an I/O cycle. INT/EOC pin is initially high, and both configuration registers are set to all zeroes. The contents of the output data register are random, and the first conversion result should be ignored. To initialize during operation,  $\overline{CS}$  is taken high and is then returned low to begin the next I/O cycle. The first conversion after the device has returned from the power-down state may not read accurately due to internal device settling.

![](_page_27_Picture_1307.jpeg)

## **Table 1. Operational Terminology**

## **Example**

In 12-bit mode, the result of the current conversion cycle is <sup>a</sup> 12-bit serial-data stream clocked out during the next I/O cycle. The current I/O cycle must be exactly 12 bits long to maintain synchronization, even when this corrupts the output data from the previous conversion. The current conversion is begun immediately after the twelfth falling edge of the current I/O cycle.

# **Default Mode**

When the DATA IN pin is held high, the ADC goes into hardware default mode because the CFGR2 bits are all programmed to the default values after eight I/O CLOCK cycles. This means the ADC is programmed for an external reference and pin 19 as EOC. In addition, channel AIN0 is selected. The first conversion is invalid therefore the conversion result should be ignored. On the next cycle, AIN0 is sampled and converted. This mode of operation is valid when CS is toggled or held low after the first cycle.

To remove the device from hardware default mode, CFGR2 bit D0 must be reset to 0. Once this is done, the host must program CFGR1 on the next cycle and disregard the result from the current cycle's conversion.

## **Data Input**

The data input is internally connected to an 8-bit serial-input address and control register. The register defines the operation of the converter and the output data length. The host provides the input data byte with the MSB first. Each data bit is clocked in on the rising edge of the I/O CLOCK sequence (see Table 2 for the data input-register format).

![](_page_28_Picture_1.jpeg)

![](_page_28_Picture_826.jpeg)

**Table 2. Command Set (CMR) and Configuration**

# **Data Input – Address/Command Bits**

The four MSBs (D7–D4) of the input data register are the address or command. These bits can be used to address one of the 11 input channels, select one of three reference-test voltages, activate the software power-down mode, or access the second configuration register, CFGR2. All address/command bits affect the current conversion, which is the conversion that immediately follows the current I/O cycle. They also allow access to CFGR1 except for command 1111b, which allows access to CFGR2.

# **Data Output Length**

CFGR1 bits (D3 and D2) of the data register select the output data length. The data-length selection is valid for the current I/O cycle (the cycle in which the data is read). The data-length selection, being valid for the current I/O cycle, allows device start-up without losing I/O synchronization. A data length of 8, 12, or 16 bits can be selected. Since the converter has 12-bit resolution, <sup>a</sup> data length of 12 bits is suggested.

With D3 and D2 set to 00 or 10, the device is in the 12-bit data-length mode and the result of the current conversion is output as <sup>a</sup> 12-bit serial data stream during the next I/O cycle. The current I/O cycle must be exactly 12 bits long for proper synchronization, even when this means corrupting the output data from <sup>a</sup> previous conversion. The current conversion is started immediately after the twelfth falling edge of the current I/O cycle.

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(default)

0: Pin 19 output EOC (default)

(CFGR1 needs to be programmed)

 (D[3:0] of CFGR1 and D[3:1] of CFGR2 set to default)

1: Pin 19 output Int 0: Normal mode

D<sub>1</sub> D0

1: Default mode enabled

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![](_page_29_Picture_2.jpeg)

With bits D3 and D2 set to 11, the 16-bit data-length mode is selected, which allows convenient communication with 16-bit serial interfaces. In the 16-bit mode, the result of the current conversion is output as <sup>a</sup> 16-bit serial data stream during the next I/O cycle with the four LSBs always reset to 0 (pad bits). The current I/O cycle must be exactly 16 bits long to maintain synchronization even when this means corrupting the output data from the previous conversion. The current conversion is started immediately after the sixteenth falling edge of the current I/O cycle.

With bits D3 and D2 set to 01, the 8-bit data-length mode is selected, which allows fast communication with 8-bit serial interfaces. In the 8-bit mode, the result of the current conversion is output as an 8-bit serial data stream during the next I/O cycle. The current I/O cycle must be exactly eight bits long to maintain synchronization, even when this means corrupting the output data from the previous conversion. The four LSBs of the conversion result are truncated and discarded. The current conversion is started immediately after the eighth falling edge of the current I/O cycle.

Because the D3 and D2 register settings take effect on the I/O cycle when the data length is programmed, there can be <sup>a</sup> conflict with the previous cycle if the data-word length was changed. This may occur when the data format is selected to be least significant bit first, since at the time the data length change becomes effective (six rising edges of I/O CLOCK), the previous conversion result has already started shifting out. In actual operation, when different data lengths are required within an application and the data length is changed between two conversions, no more than one conversion result can be corrupted and only when it is shifted out in LSB-first format.

# **LSB Out First**

D1 in the CFGR1 controls the direction of the output (binary) data transfer. When D1 is reset to 0, the conversion result is shifted out MSB first. When set to 1, the data is shifted out LSB first. Selection of MSB first or LSB first always affects the next I/O cycle and not the current I/O cycle. When changing from one data direction to another, the current I/O cycle is never disrupted.

## **Bipolar Output Format**

D0 in the CFGR1 controls the binary data format used to represent the conversion result. When D0 is cleared to 0, the conversion result is represented as unipolar (unsigned binary) data. Nominally, the conversion result of an input voltage equal to or less than  $V_{REF-}$  is a code with all zeros (000...0) and the conversion result of an input voltage equal to or greater than  $V_{REF+}$  is a code of all ones (111...1). The conversion result of  $(V_{REF+} + V_{REF-})/2$  is <sup>a</sup> code of <sup>a</sup> one followed by zeros (100 ...0).

When D0 is set to 1, the conversion result is represented as bipolar (signed binary) data. Nominally, conversion of an input voltage equal to or less than  $V_{REF-}$  is a code of a one followed by zeros (100...0), and the conversion of an input voltage equal to or greater than  $V_{REF+}$  is a code of a zero followed by all ones (011...1). The conversion result of  $(V_{REF+} + V_{RFE})/2$  is a code of all zeros (000...0). The MSB is interpreted as the sign bit. The bipolar data format is related to the unipolar format in that the MSBs are always each other's complement.

Selection of the unipolar or bipolar format always affects the current conversion cycle, and the result is output during the next I/O cycle. When changing between unipolar and bipolar formats, the data output during the current I/O cycle is not affected.

## **Reference**

The device has <sup>a</sup> built-in reference with <sup>a</sup> programmable level of 2.048 V or 4.096 V. If the internal reference is used, REF+ is set to 2.048 V or 4.096 V and REF– is set to analog GND. An external reference can also be used through two reference input pins, REF+ and REF–, if the reference source is programmed as external. The voltage levels applied to these pins establish the upper and lower limits of the analog inputs to produce <sup>a</sup> full-scale and zero-scale reading respectively. The values of REF+, REF–, and the analog input should not exceed the positive supply or be lower than GND consistent with the specified absolute maximum ratings. The digital output is at full scale when the input signal is equal to or higher than REF+ and at zero when the input signal is equal to or lower than REF–.

![](_page_30_Picture_0.jpeg)

![](_page_30_Figure_3.jpeg)

**Figure 54. Reference Block**

# **INT/EOC Output**

Pin 19 outputs the status of the ADC conversion. When programmed as EOC, the output indicates the beginning and the end of conversion. In the reset state, EOC is always high. During the sampling period (beginning after the fourth falling edge of the I/O CLOCK sequence), EOC remains high until the internal sampling switch of the converter is safely opened. The opening of the sampling switch occurs after the eighth, twelfth, or sixteenth I/O CLOCK falling edge, depending on the data-length selection in the input data register. After the EOC signal goes low, the analog input signal can be changed without affecting the conversion result.

The EOC signal goes high again after the conversion is completed and the conversion result is latched into the output data register. The rising edge of EOC returns the converter to <sup>a</sup> reset state and <sup>a</sup> new I/O cycle begins. On the rising edge of EOC, the first bit of the current conversion result is on DATA OUT when CS is low. When CS is toggled between conversions, the first bit of the current conversion result occurs on DATA OUT at the falling edge of CS.

When programmed as  $\overline{\text{INT}}$ , the output indicates that the conversion is completed and the output data is ready to be read. In the reset state,  $\overline{INT}$  is always high.  $\overline{INT}$  is high during the sampling period and until the conversion is complete. After the conversion is finished and the output data is latched, INT goes low and remains low until it is cleared by the host. When CS is held low, the MSB (or LSB) of the conversion result is presented on DATA OUT on the falling edge of INT. A rising I/O CLOCK edge clears the interrupt.

# **Chip-Select Input (CS)**

CS enables and disables the device. During normal operation, CS should be low. Although the use of CS is not necessary to synchronize <sup>a</sup> data transfer, it can be brought high between conversions to coordinate the data transfer of several devices sharing the same bus.

When  $\overline{\text{CS}}$  is brought high, the serial-data output is immediately brought to the high-impedance state, releasing its output data line to other devices that may share it. After an internally generated debounce time, I/O CLOCK is inhibited, thus preventing any further change in the internal state.

When  $\overline{CS}$  is subsequently brought low again, the device is reset.  $\overline{CS}$  must be held low for an internal debounce time before the reset operation takes effect. After  $\overline{CS}$  is debounced low, I/O CLOCK must remain inactive (low) for <sup>a</sup> minimum time before <sup>a</sup> new I/O cycle can start.

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#### $\text{SLASS98A–NOVEMBER 2008–REVISED JULY 2009 \hspace{20.0371} \text{GeVI, a} \text{LOM} \text{UVW-1} \text{LCO} \text{UVW-1} \text{UVW-1} \text{UVW-1} \text{U} \text{U} \text{U} \text{V} \text{U} \text{U} \text{U} \text{V} \text{U} \text{U} \text{U} \text{V} \text{U} \text{U} \text{V} \text{U} \text{U} \text{U} \text{V} \text{U} \text{U} \text{U} \text{U} \text{U} \text{U} \text{$

![](_page_31_Picture_2.jpeg)

CS can interrupt any ongoing data transfer or any ongoing conversion. When CS is debounced low long enough before the end of the current conversion cycle, the previous conversion result is saved in the internal output buffer and shifted out during the next I/O cycle.

When CS is held low continuously for multiple cycles, the first data bit of the newly completed conversion occurs on DATA OUT on the rising edge of EOC or falling edge of INT. Note that the first cycle in the series still requires <sup>a</sup> transition of CS from high to low. When <sup>a</sup> new conversion is started after the last falling edge of I/O CLOCK, EOC goes low and the serial output is forced low until EOC goes high again.

When CS is toggled between conversions, the first data bit occurs on DATA OUT on the falling edge of CS. On each subsequent falling edge of I/O CLOCK after the first data bit appears, the data is changed to the next bit in the serial conversion result until the required number of bits has been output.

### **Power-Down Features**

When command (D7–D4) 1110b is clocked into the input data register during the first four I/O CLOCK cycles, the software power-down mode is selected. Software power down is activated on the falling edge of the fourth I/O CLOCK pulse.

During software power down, all internal circuitry is put in <sup>a</sup> low-current standby mode. The internal reference (if being used) is powered down. No conversion is performed. The internal output buffer keeps the previous conversion cycle data results provided that all digital inputs are held above  $V_{CC}$  – 0.5 V or below 0.5 V. The I/O logic remains active so the current I/O cycle must be completed even when the power-down mode is selected. Upon power-on reset and before the first I/O cycle, the converter normally begins in the power-down mode. The device remains in the software power-down mode until <sup>a</sup> valid input address (other than command 1110b) is clocked in. Upon completion of that I/O cycle, <sup>a</sup> normal conversion is performed with the results being shifted out during the next I/O cycle. If using the internal reference, care must be taken to allow the reference to power on completely before <sup>a</sup> valid conversion can be performed. It requires 1 ms to resume from <sup>a</sup> software power down.

The ADC also has an auto power-down mode. This is transparent to users. The ADC goes into auto power down within one I/O CLOCK cycle after the conversion is complete and resumes, with <sup>a</sup> small delay after an active CS is sent to the ADC. This mode keeps built-in reference so resumption is fast enough to be used between cycles.

## **Analog Multiplexer**

The 11 analog inputs, three internal voltages, and power-down mode are selected by the input multiplexer according to the input addresses shown in Table 2. The input multiplexer is <sup>a</sup> break-before-make type to reduce input-to-input noise rejection resulting from channel switching. Sampling of the analog inputs starts on the falling edge of the fourth I/O CLOCK and continues for the remaining I/O CLOCK pulses. The sample is held on the falling edge of the last I/O CLOCK pulse. The three internal test inputs are applied to the multiplexer, then sampled and converted in the same manner as the external analog inputs. The first conversion after the device has returned from the power-down state may not read accurately due to internal device settling.

![](_page_32_Picture_0.jpeg)

# **PACKAGING INFORMATION**

![](_page_32_Picture_231.jpeg)

**(1)** The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

**(3)** MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

**(4)** There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

**(5)** Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

**(6)** Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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![](_page_33_Picture_0.jpeg)

# **PACKAGE OPTION ADDENDUM**

#### **OTHER QUALIFIED VERSIONS OF TLV2556-EP :**

<sub>●</sub> Catalog : [TLV2556](http://focus.ti.com/docs/prod/folders/print/tlv2556.html)

NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product

![](_page_34_Picture_1.jpeg)

**TEXAS** 

# **TAPE AND REEL INFORMATION**

**ISTRUMENTS** 

![](_page_34_Figure_4.jpeg)

![](_page_34_Figure_5.jpeg)

### **QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**

![](_page_34_Figure_7.jpeg)

![](_page_34_Picture_229.jpeg)

![](_page_35_Picture_0.jpeg)

# **PACKAGE MATERIALS INFORMATION**

www.ti.com 14-Mar-2024

![](_page_35_Figure_4.jpeg)

\*All dimensions are nominal

![](_page_35_Picture_71.jpeg)

![](_page_36_Picture_1.jpeg)

# **PACKAGE OUTLINE**

# **PW0020A TSSOP - 1.2 mm max height**

SMALL OUTLINE PACKAGE

![](_page_36_Figure_5.jpeg)

NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.

![](_page_36_Picture_12.jpeg)

# **EXAMPLE BOARD LAYOUT**

# **PW0020A TSSOP - 1.2 mm max height**

SMALL OUTLINE PACKAGE

![](_page_37_Figure_4.jpeg)

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

![](_page_37_Picture_8.jpeg)

# **EXAMPLE STENCIL DESIGN**

# **PW0020A TSSOP - 1.2 mm max height**

SMALL OUTLINE PACKAGE

![](_page_38_Figure_4.jpeg)

NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.

![](_page_38_Picture_8.jpeg)

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